

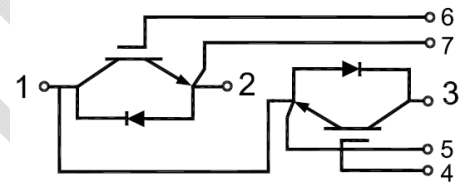


# GT400HF120T2NH

## IGBT Module

### Features:

- Field Stop Trench Gate IGBT
- Short Circuit Rated >10 $\mu$ s
- Low Saturation Voltage
- Low Switching Loss
- 100% RBSOA Tested(2 $\times$ Ic)
- Low Stray Inductance
- Lead Free, Compliant with RoHS Requirement



### Applications:

- High power converters
- Motor drives
- UPS systems
- Wind turbines

### Maximum Rated Values of IGBT

V <sub>CES</sub>	Collector-Emitter Blocking Voltage	T <sub>J</sub> =25°C	1200	V
V <sub>GES</sub>	Gate-Emitter Voltage		±20	V
I <sub>C</sub>	Continuous Collector Current	T <sub>C</sub> =100°C	400	A
		T <sub>C</sub> =25°C	720	A
I <sub>CM</sub>	Repetitive Peak Collector Current	t <sub>p</sub> =1ms	800	A
t <sub>SC</sub>	Short Circuit Withstand Time		>10	μs
P <sub>D</sub>	Maximum Power Dissipation per IGBT	T <sub>C</sub> =25°C T <sub>Jmax</sub> =175°C	2445	W



## Electrical Characteristics of IGBT

### Static Characteristics

Symbol	Description	Conditions	Min	Typ	Max	Unit	
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=4mA, V_{CE}=V_{GE}, T_J=25^\circ C$	5.0	5.6	6.6	V	
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$I_C=400A, V_{GE}=15V$	$T_J=25^\circ C$		1.70		V
			$T_J=125^\circ C$		1.90		V
			$T_J=150^\circ C$		2.00		V
$I_{CES}$	Collector-Emitter Leakage Current	$V_{GE}=0V, V_{CE}=V_{CES}, T_J=25^\circ C$			1	mA	
$I_{GES}$	Gate-Emitter Leakage Current	$V_{GE}=\pm 20V, V_{CE}=0V, T_J=25^\circ C$			400	nA	
$C_{ies}$	Input Capacitance	$V_{CE}=25V, V_{GE}=0V, f=1MHz, T_J=25^\circ C$		33.02		nF	
$C_{oes}$	Output Capacitance			2.42		nF	
$C_{res}$	Reverse Transfer Capacitance			1.35		nF	

### Switching Characteristics

$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=600V, I_C=400A, R_{Gon}=1\Omega, V_{GE}=\pm 15V, \text{Inductive Load}$	$T_J=25^\circ C$		0.44		$\mu s$
			$T_J=125^\circ C$		0.45		
			$T_J=150^\circ C$		0.45		
$t_r$	Rise Time		$T_J=25^\circ C$		0.15		$\mu s$
			$T_J=125^\circ C$		0.16		
			$T_J=150^\circ C$		0.16		
$t_{d(off)}$	Turn-off Delay Time		$T_J=25^\circ C$		0.43		$\mu s$
			$T_J=125^\circ C$		0.46		
			$T_J=150^\circ C$		0.47		
$t_f$	Fall Time	$T_J=25^\circ C$		0.12		$\mu s$	
		$T_J=125^\circ C$		0.16			
		$T_J=150^\circ C$		0.18			
$E_{on}$	Turn-on Switching Loss	$V_{CC}=600V, I_C=400A, R_{Gon}=1\Omega, V_{GE}=\pm 15V, di/dt=2056A/\mu s (T_J=150^\circ C) \text{ Inductive Load}$	$T_J=25^\circ C$		28		mJ
		$T_J=125^\circ C$		39.8			
		$T_J=150^\circ C$		42.7			



E <sub>off</sub>	Turn-off Switching Loss	V <sub>CC</sub> =600V, I <sub>C</sub> =400A, R <sub>Goff</sub> =1Ω, V <sub>GE</sub> = ±15V, du/dt=3115V/μs ( T <sub>J</sub> =150°C) Inductive Load	T <sub>J</sub> =25°C	39.1	mJ
			T <sub>J</sub> =125°C	51.2	
			T <sub>J</sub> =150°C	54.6	
Q <sub>g</sub>	Total Gate Charge	V <sub>GE</sub> =+15V...-15V	T <sub>J</sub> =25°C	2.18	μC
R <sub>g internal</sub>	Internal gate resistance		T <sub>J</sub> =25°C	1.75	Ω
RBSOA	I <sub>C</sub> =800A, V <sub>CC</sub> =1050V, V <sub>p</sub> =1200V, R <sub>Goff</sub> = 1Ω, V <sub>GE</sub> =+15V to 0V, T <sub>J</sub> =150°C		Trapezoid		
I <sub>SC</sub>	SC Data	V <sub>GE</sub> =± 15V, V <sub>CC</sub> =600V, R <sub>Gon</sub> =1Ω, R <sub>Goff</sub> =1Ω, tp=10us , Inductive Load, T <sub>J</sub> =150°C		1931	A
R <sub>θJC</sub>	IGBT Thermal Resistance: Junction-To-Case(per leg)			0.061	°C/W

### Maximum Rated Values of Diode

V <sub>RRM</sub>	Repetitive Peak Reverse Voltage	T <sub>J</sub> =25°C	1200	V
I <sub>F</sub>	Diode Continuous Forward Current		400	A
I <sub>FM</sub>	Diode Maximum Forward Current	tp=1ms	800	A

### Electrical Characteristics of Diode

Symbol	Description	Conditions	Min	Typ	Max	Unit
V <sub>FM</sub>	Forward Voltage	I <sub>F</sub> =400A	T <sub>J</sub> =25°C	1.40		V
			T <sub>J</sub> =125°C	1.50		
			T <sub>J</sub> =150°C	1.45		
t <sub>rr</sub>	Reverse Recovery Time		T <sub>J</sub> =25°C	0.46		μs
			T <sub>J</sub> =125°C	0.66		
			T <sub>J</sub> =150°C	0.74		
I <sub>rr</sub>	Peak Reverse Recovery Current	I <sub>F</sub> =400A, -diF/dt =2380A/μs(T <sub>J</sub> =150°C), V <sub>R</sub> =600V, V <sub>GE</sub> =-15V	T <sub>J</sub> =25°C	263		A
			T <sub>J</sub> =125°C	300		
			T <sub>J</sub> =150°C	306		
Q <sub>rr</sub>	Reverse Recovery Charge		T <sub>J</sub> =25°C	64		μC
			T <sub>J</sub> =125°C	101		
			T <sub>J</sub> =150°C	115		



E <sub>rec</sub>	Reverse Recovery Energy	I <sub>F</sub> =400A, -diF/dt =2380A/μs(T <sub>J</sub> =15°C0), V <sub>R</sub> =600V, V <sub>GE</sub> =-15V	T <sub>J</sub> =25°C	28.9	mJ
			T <sub>J</sub> =125°C	44.8	
			T <sub>J</sub> =150°C	51.4	
R <sub>θJC</sub>	Diode Thermal Resistance: Junction-To-Case (per leg)			0.103	°C/W

## Module

Symbol	Description		Min	Typ	Max	Unit
V <sub>iso</sub>	Isolation Voltage (All Terminals Shorted)	f = 50Hz, 1minute	2500			V
Material of Module Baseplate			Copper			
Internal Isolation			Al2O3			
L <sub>SCE</sub>	Stray Inductance Module			14		nH
T <sub>J</sub>	Maximum Junction Temperature				175	°C
T <sub>JOP</sub>	Maximum Operating Junction Temperature Range		-40		+150	°C
T <sub>stg</sub>	Storage Temperature		-40		+125	°C
CTI	Comparative Tracking Index		200			
R <sub>θCS</sub>	Case-To-Sink Thermally (Conductive Grease Applied)				0.03	°C/W
T	Power Terminals Screw:M6		3.0		5.0	N·m
T	Mounting Screw:M6		4.0		6.0	N·m
G	Weight			300		g



## Ordering Information Table

Device code	G	T	400	HF	120	T2N	H
	①	②	③	④	⑤	⑥	⑦

- ①-IGBT Module
- ②-Field Stop Trench Gate IGBT
- ③-Rated Current (400=400A)
- ④-Circuit Configuration: HF (Half Bridge)
- ⑤-Rated Voltage (120=1200V)
- ⑥-Package Type
- ⑦-Test Level (Pass the Important Reliability Test-Industrial Grade)

DATA SHEET

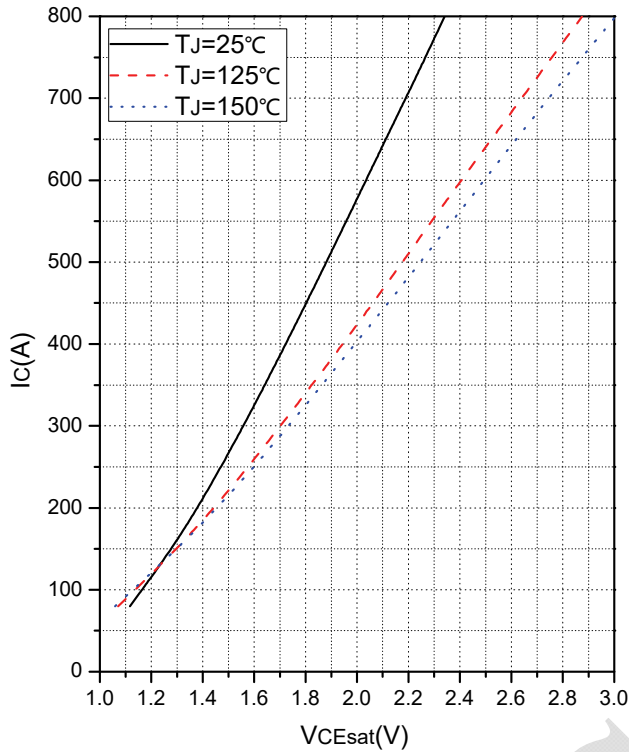


Fig.1 Typical Saturation Voltage Characteristics

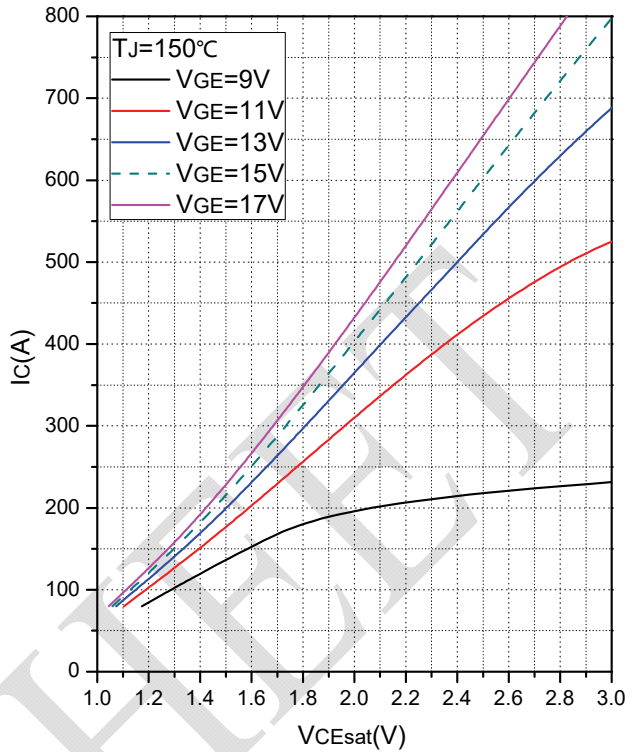


Fig.2 Typical Output Characteristics

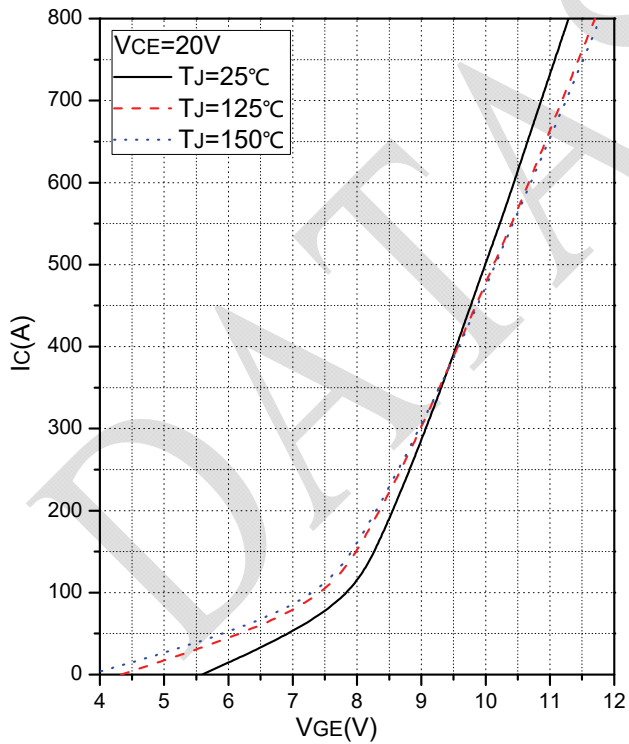


Fig.3 Transfer Characteristic

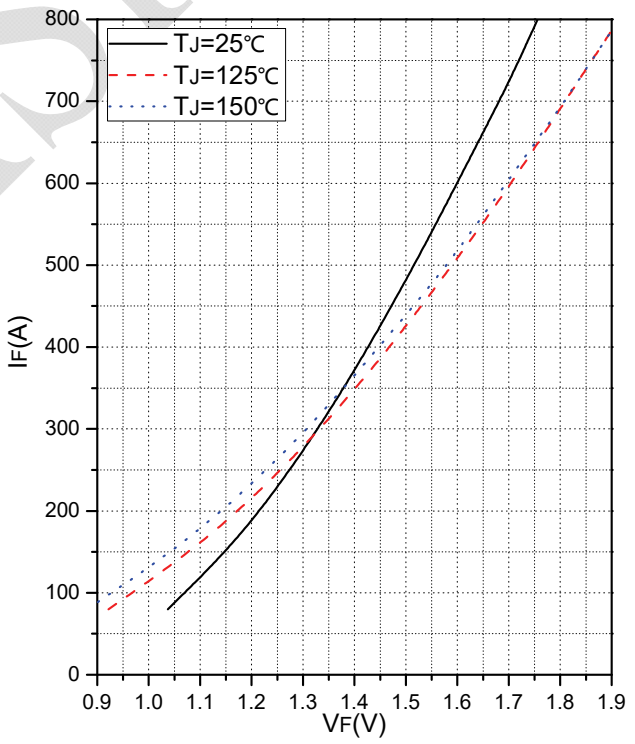


Fig.4 Forward Characteristics of Diode

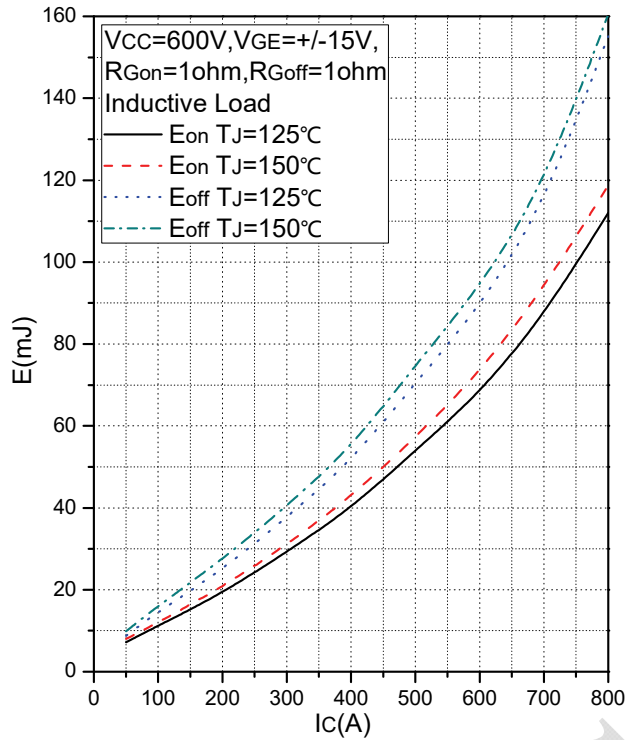


Fig.5 Typical Switching Loss vs. Collector Current

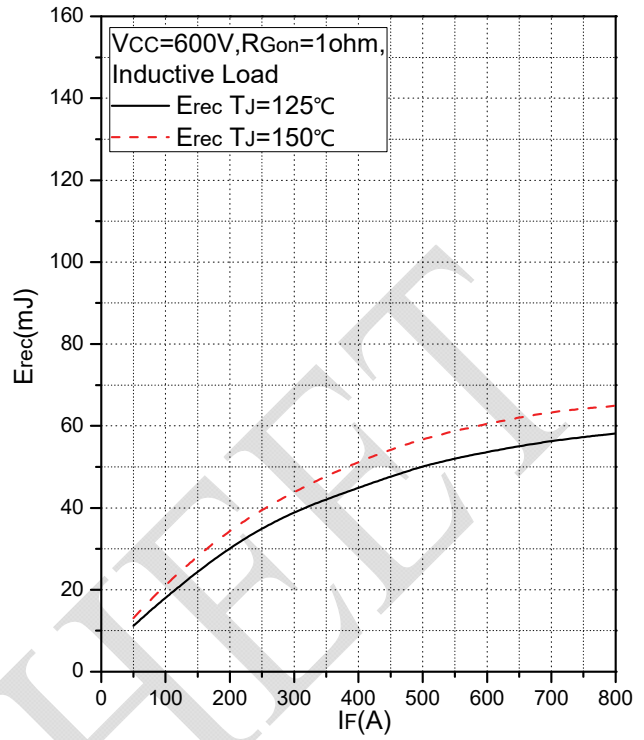


Fig.6 Typical Switching Loss vs. Forward Current

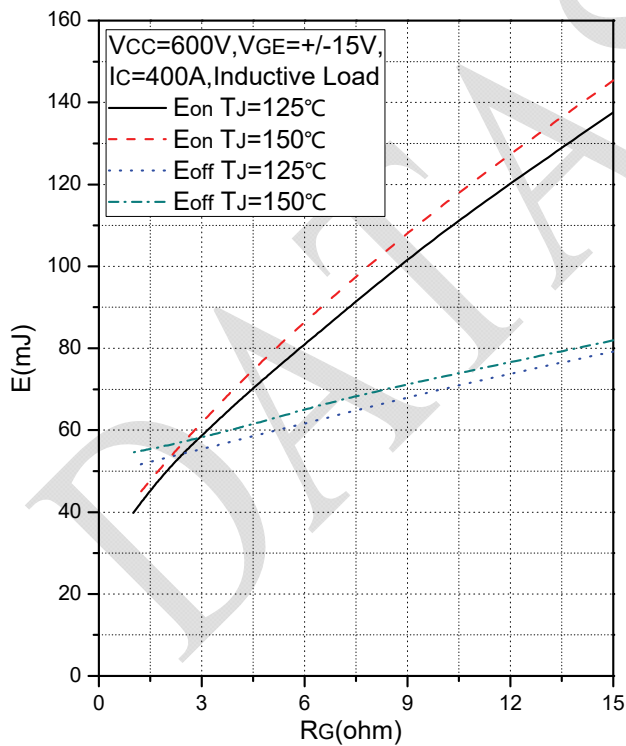


Fig.7 Typical Switching Loss vs. Gate Resistance

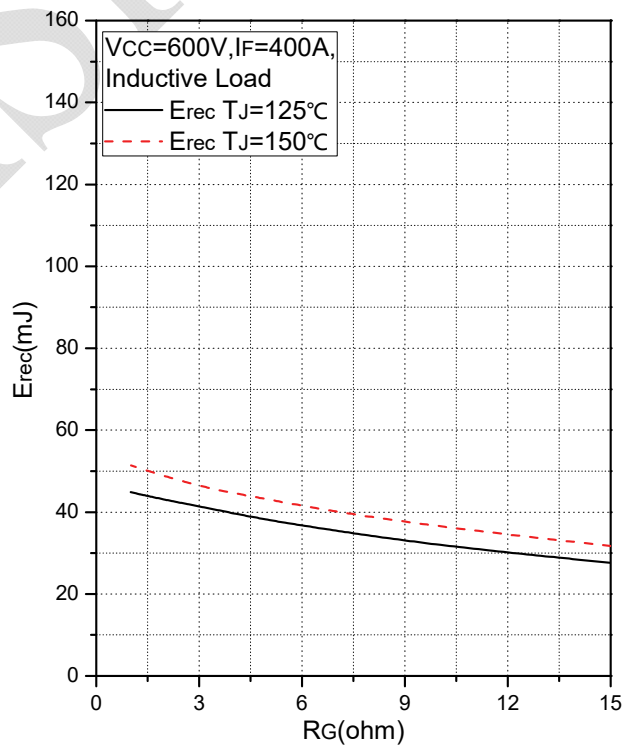


Fig.8 Typical Switching Loss vs. Gate Resistance

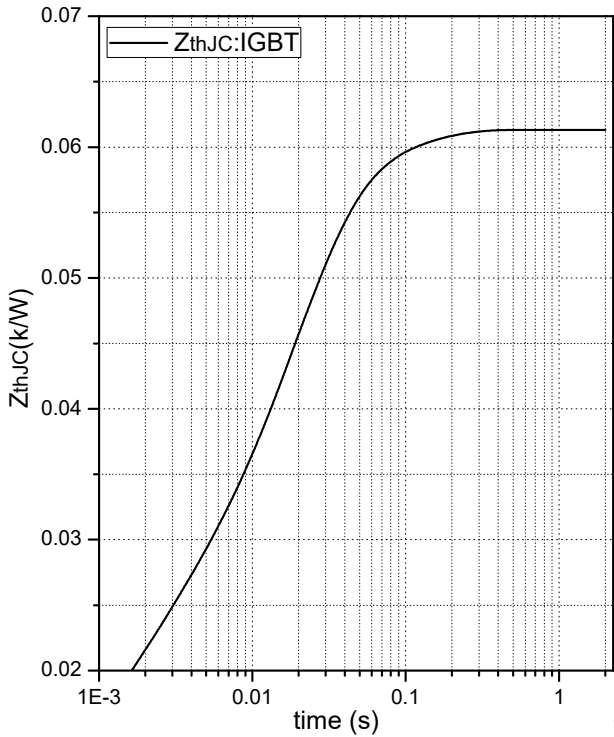


Fig.9 Transient Thermal Impedance (IGBT)

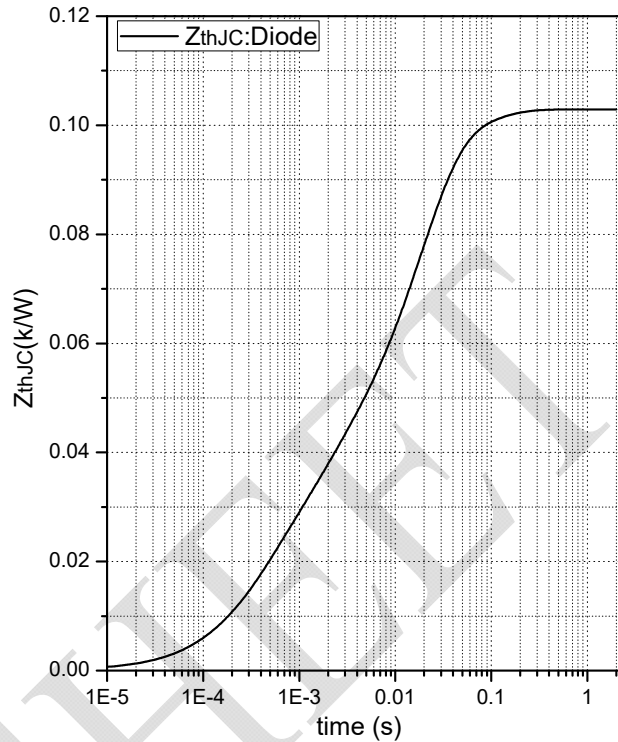


Fig.10 Transient Thermal Impedance (Diode)

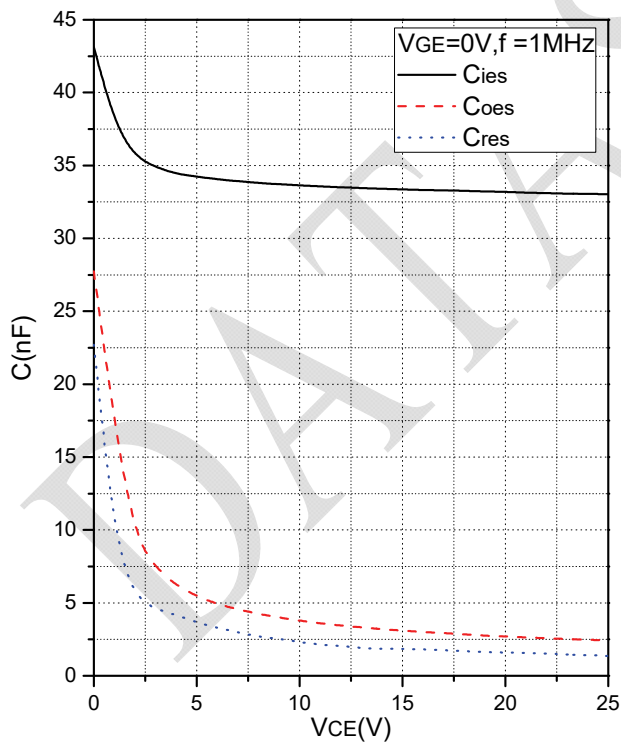


Fig.11 Capacitance Characteristics

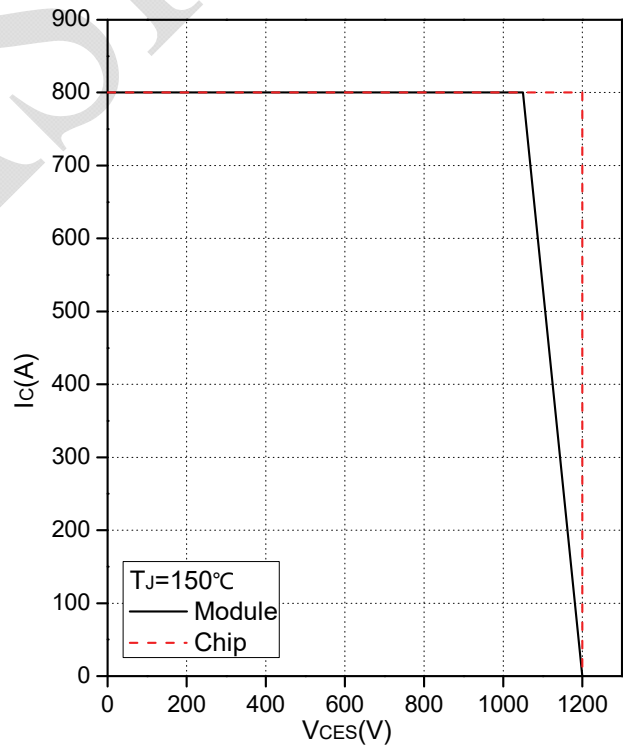


Fig.12 Reverse Bias Safe Operation Area (RBSOA)

## Internal Circuit







Date	Revision	Notes
07/27/2020	A	Final Version

## Announcement

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